

# SEMITRANS® 2

## Trench IGBT Modules

### **SKM75GB07E3**

#### Features\*

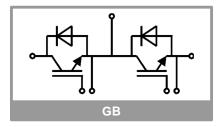
- V<sub>CE(sat)</sub> with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I<sub>Cnom</sub>
- Fast & soft switching inverse CAL diodes
- Insulated copper baseplate using DCB Technology (Direct Copper Bonding)
- With integrated gate resistor

## **Typical Applications**

- AC inverter drives
- UPS
- Electronic welders
- Wind power
- Public transport

#### Remarks

- Case temperature limited to  $T_c = 125$ °C max.
- Recommended  $T_{op} = -40 \dots +150$ °C
- Product reliability results valid for  $T_j = 150$  °C
- Use of soft R<sub>G</sub> necessary



Absolute	Maximum Rating	js .		
Symbol	Conditions		Values	Unit
IGBT	•			
V <sub>CES</sub>	T <sub>j</sub> = 25 °C		650	V
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	99	А
		$T_c = 80  ^{\circ}C$	74	Α
I <sub>Cnom</sub>			75	Α
I <sub>CRM</sub>			225	Α
$V_{GES}$			-20 20	V
t <sub>psc</sub>	$V_{CC} = 360 \text{ V} $ $V_{GE} \le 15 \text{ V} $ $V_{CES} \le 650 \text{ V} $	T <sub>j</sub> = 150 °C	6	μs
Tj			-40 175	°C
Inverse di	iode			
$V_{RRM}$	T <sub>j</sub> = 25 °C		650	٧
I <sub>F</sub>	T <sub>j</sub> = 175 °C	$T_c = 25  ^{\circ}\text{C}$ $T_c = 80  ^{\circ}\text{C}$	84	А
	1) = 175 C	$T_c = 80  ^{\circ}C$	62	A
I <sub>FRM</sub>			100	Α
I <sub>FSM</sub>	$t_p = 10 \text{ ms, sin } 180^{\circ}, T_j = 25 ^{\circ}\text{C}$		550	Α
Tj			-40 175	ŝ
Module				
I <sub>t(RMS)</sub>			200	А
T <sub>stg</sub>	module without	ГІМ	-40 125	°C
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min		4000	V

Characteristics									
Symbol	Conditions		min.	typ.	max.	Unit			
IGBT									
	I <sub>C</sub> = 75 A	T <sub>j</sub> = 25 °C		1.45	1.77	V			
V <sub>CE(sat)</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		1.72	2.10	V			
.,	chiplevel	T <sub>j</sub> = 25 °C		0.90	1.00	V			
$V_{CE0}$		T <sub>j</sub> = 150 °C		0.82	0.90	V			
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		7.3	10	mΩ			
		T <sub>j</sub> = 150 °C		12	16	mΩ			
V <sub>GE(th)</sub>	$V_{GE} = V_{CE}$ , $I_C = 1.2$ mA		5.1	5.8	6.4	V			
I <sub>CES</sub>	$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}, T_j = 25 \text{ °C}$				0.3	mA			
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		4.6		nF			
Coes		f = 1 MHz		0.30		nF			
C <sub>res</sub>		f = 1 MHz		0.14		nF			
$Q_G$	V <sub>GE</sub> = -8V + 15 V			680		nC			
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			4.0		Ω			
t <sub>d(on)</sub>	V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C		72		ns			
tr	I <sub>C</sub> = 75 A V <sub>GE</sub> =+15/-15V R <sub>Gon</sub> = 1 Ω	T <sub>j</sub> = 150 °C		30		ns			
Eon		T <sub>j</sub> = 150 °C		2.4		mJ			
t <sub>d(off)</sub>	R <sub>Goff</sub> = 1 Ω	T <sub>j</sub> = 150 °C		250		ns			
t <sub>f</sub>	di/dt <sub>on</sub> = 2500 A/µs	T <sub>j</sub> = 150 °C		50		ns			
E <sub>off</sub>	$\begin{array}{l} \text{di/dt}_{\text{off}} = 1250 \text{ A/}\mu\text{s} \\ \text{dv/dt} = 4030 \text{ V/}\mu\text{s} \end{array}$	T <sub>j</sub> = 150 °C		2.7		mJ			
R <sub>th(j-c)</sub>	per IGBT				0.591	K/W			
R <sub>th(c-s)</sub>	per IGBT, P12 (reference)			0.090		K/W			
R <sub>th(c-s)</sub>	per IGBT, HP-PCM			0.050		K/W			



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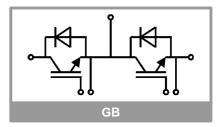
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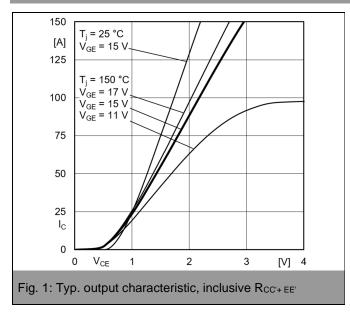
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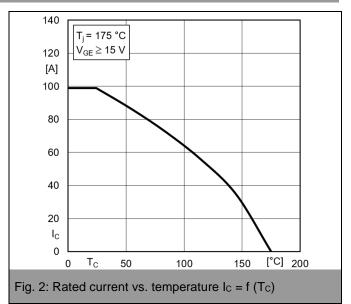
#### Remarks

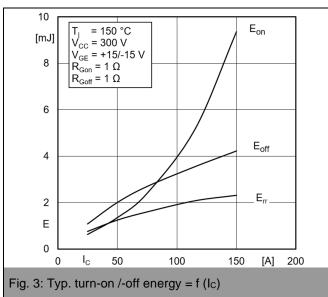
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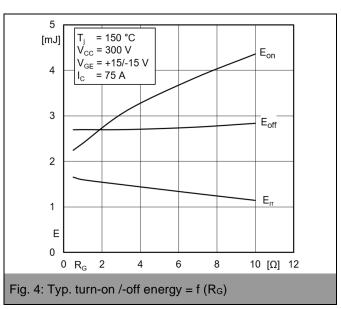
Characteristics							
Symbol	Conditions	min.	typ.	max.	Unit		
Inverse o	diode						
$V_F = V_{EC}$	$I_F = 75 \text{ A}$ $V_{GE} = 0 \text{ V}$ chiplevel	T <sub>j</sub> = 25 °C		1.37	1.73	V	
		T <sub>j</sub> = 150 °C		1.35	1.72	V	
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.04	1.24	V	
		T <sub>j</sub> = 150 °C		0.85	0.99	V	
r <sub>F</sub>	ala Sa Lacca I	T <sub>j</sub> = 25 °C		6.7	9.8	mΩ	
	chiplevel	T <sub>j</sub> = 150 °C		10	15	mΩ	
I <sub>RRM</sub>	V <sub>CC</sub> = 300 V	T <sub>j</sub> = 150 °C		87		Α	
Q <sub>rr</sub>	I <sub>F</sub> = 75 A V <sub>GF</sub> = -15 V	T <sub>j</sub> = 150 °C		7.8		μC	
Err	$di/dt_{off} = 2740 \text{ A/}\mu\text{s}$	s T <sub>j</sub> = 150 °C		1.6		mJ	
R <sub>th(j-c)</sub>	per diode			0.85	K/W		
R <sub>th(c-s)</sub>	per diode, P12 (reference)			0.108		K/W	
R <sub>th(c-s)</sub>	per diode, HP-PCM			0.059		K/W	
Module							
L <sub>CE</sub>				30		nΗ	
D	measured per	T <sub>j</sub> = 25 °C		0.65		mΩ	
R <sub>CC'+EE'</sub>	switch	T <sub>j</sub> = 150 °C		1.09		mΩ	
$R_{\text{th(c-s)1}}$	calculated without thermal coupling, P12 (reference)			0.025		K/W	
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module, P12 (reference)			0.040		K/W	
R <sub>th(c-s)2</sub>	including thermal coupling, T <sub>s</sub> underneath module, HP-PCM			0.022		K/W	
Ms	to heat sink M6		3		5	Nm	
Mt	to	terminal M5	2.5		5	Nm	
				-		Nm	
W			<u> </u>		160	g	

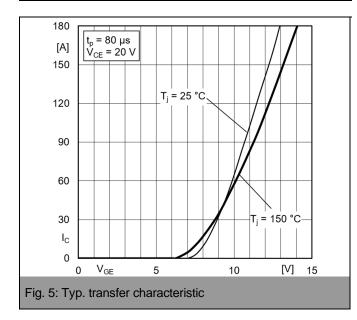


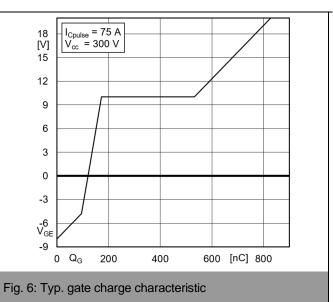


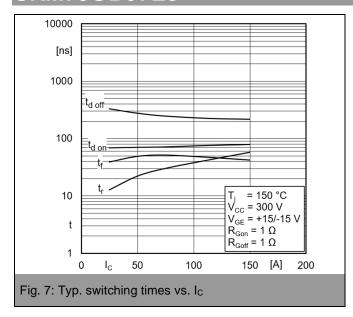


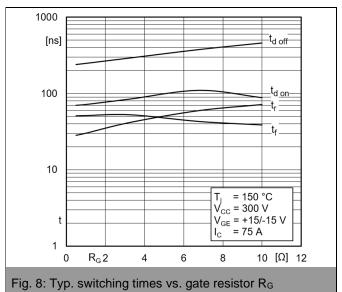


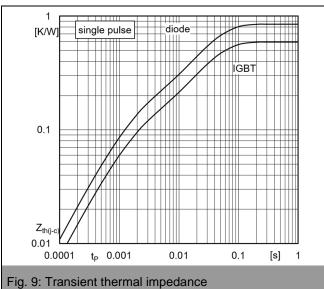


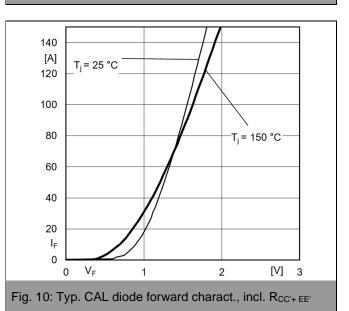


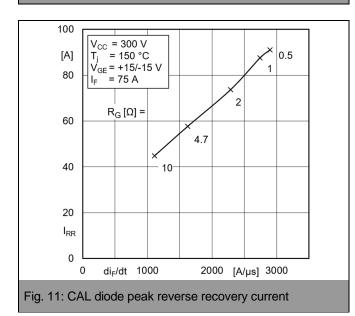


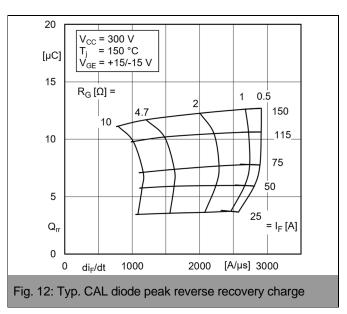


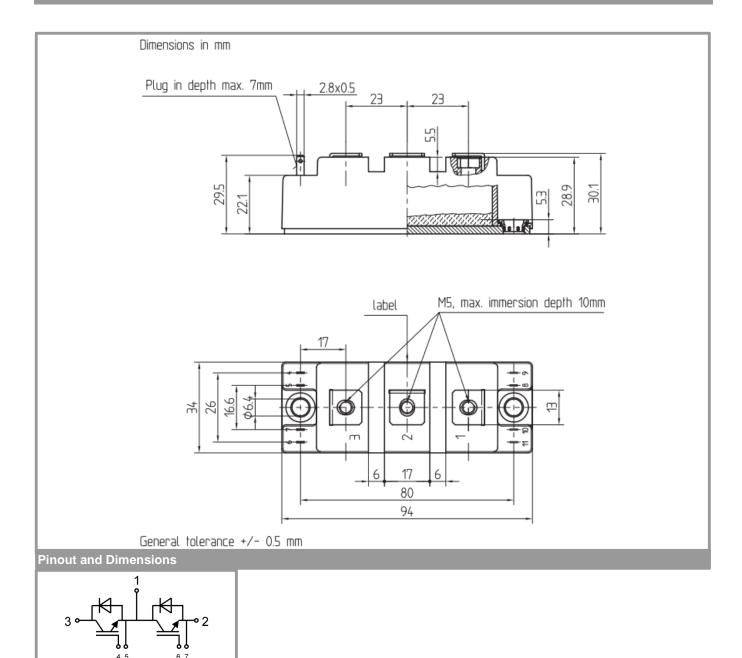












This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

### \*IMPORTANT INFORMATION AND WARNINGS

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